


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588316	<b>Applicant(s)/Patent Under Reexamination</b>  MIURA ET AL.
	<b>Examiner</b>  Min Shin	<b>Art Unit</b>  3688

### SEARCHED

Class	Subclass	Date	Examiner
705	14	5/22/2009	MS
705	14.71	21 May 2010	DLC

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (USPAT, PGPUB, DERWENT, JPO, EPO)	5/22/2009	MS
EAST searches "classif", "bid_ratio", "sum_ratio" and "CTR_sum_ratio"	21 May 2010	DLC
Dialog Quick Search for NPL (in two parts)	21 May 2010	DLC

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
705	14.71	21 May 2010	DLC

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